DIAGNOSTICS OF ULTRASHORT ELECTRON BUNCHES DEVELOPED AT JINR O. Brovko, D. Kharlamov, S. Kostromin, O. Kozlov, R. Makarov, E. Matyushevskiy, N.Morozov, E. Syresin*, B. Zalikhanov, M. Yurkov, JINR, Russia.

FLASH diagnostics:

MCP-based photon detectors Bunch length diagnostic on basis of FAR infrared undulator Proposed XFEL diagnostics MCP-based detectors for SASE XFEL Optical Replica synthesizer Laser heater Hybrid Pixel Array Detector. ILC diagnostics: Magnetic spectrometer for electron energy measurements Synchrotron radiation detector for electron energy measurements

PARAMETERS OF ULTRASHORT ELECTRON BUNCHES

Parameters	FLASH	XFEL	ILC
Electron energy, GeV	1	17.5	250
Bunch charge, nC	1	1	3.2
Normalized emittance, π·mm·mrad	2	1.4	10/0.04
Bunch length, μm	50	25	300
Bunch repetition rate, MHz	2	5	2.7

MCP based photon detector

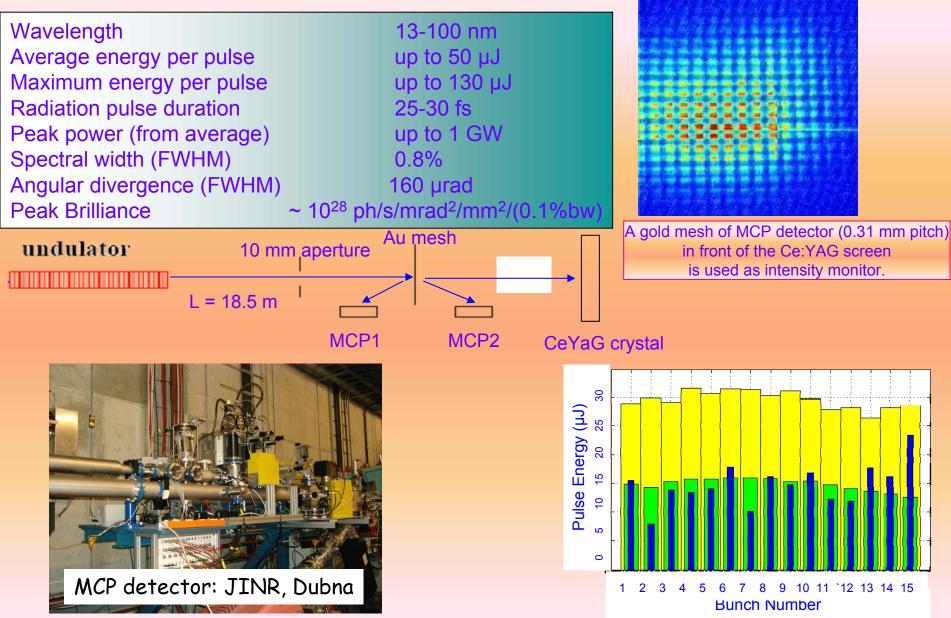
FLASH operation strongly depends on the quality of the radiation detector:

wide wavelength range (from 6 to 100 nm), wide dynamic range (from the spontaneous emission level to the saturation level)

high relative accuracy of measurements which is crucial for detection of radiation amplification and characterization of statistical properties of the radiation.

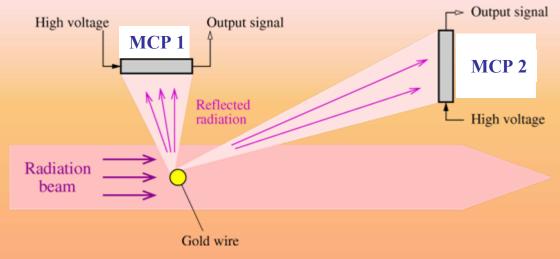
Key element of the detector is wide dynamic range MCP which detects scattered radiation from a target.

Parameters of FEL radiation, FLASH MCP detector in 2004-2007

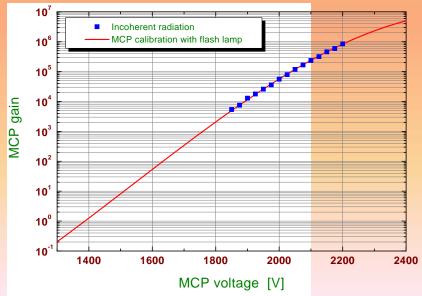


MCP detector JINR provides construction and electronic developments

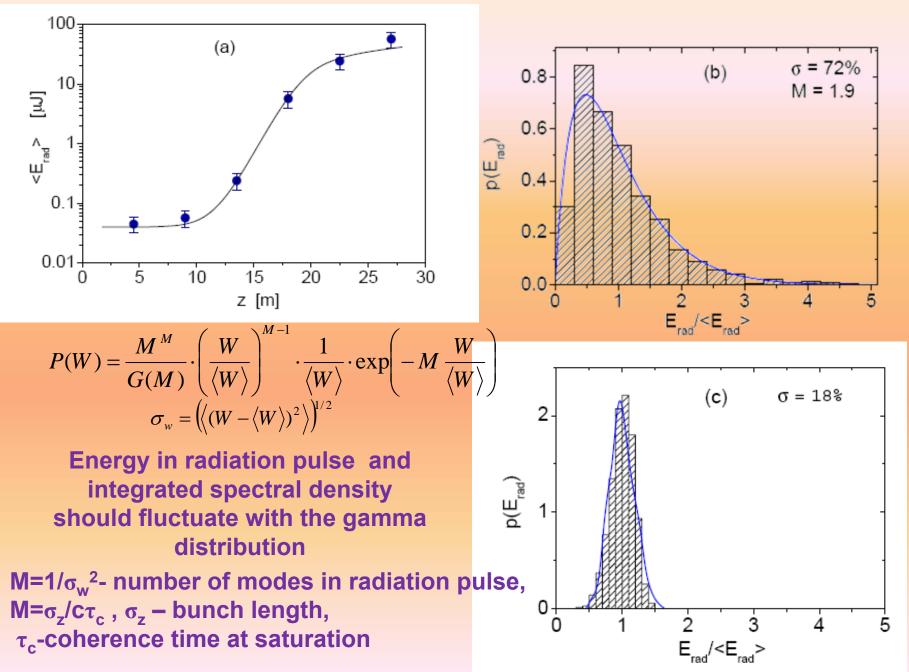




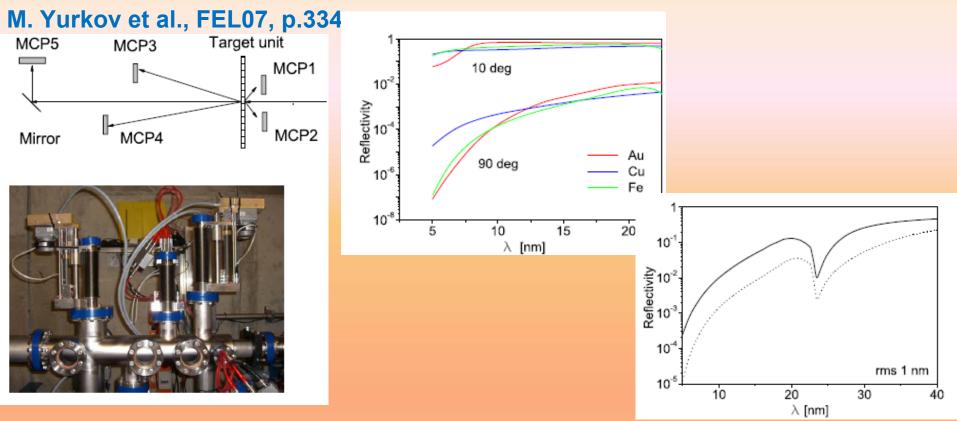




FLASH MCP MEASHUREMENTS



MCP detector with extended wavelength



Layout of MCP detector (version MCP07) with extended wave length installed at FLASH in 2007.

Present FLASH detector covers wavelength range from 6 to 100 nm, and dynamic range of the radiation intensities, from the level of spontaneous emission up to the saturation level of SASE FEL.

The gold target is perfect for use in the wavelength range above 10 nm, however its reflectivity falls dramatically for shorter wavelengths. Additionally to gold mesh, we added three more targets: two iron meshes (88% and 79% open area), and one copper mesh (60% open area).

Construction of FLASH FIR undulator in JINR



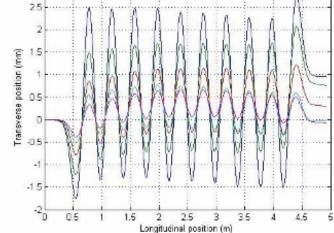
2006, JINR Workshop



Magnetic measurements of infrared undulator at DLNP test bench



January 2007, JINR



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JINR infrared undulator applied for short bunch measurements and pump probe experiments in FLASH-DESY tunnel



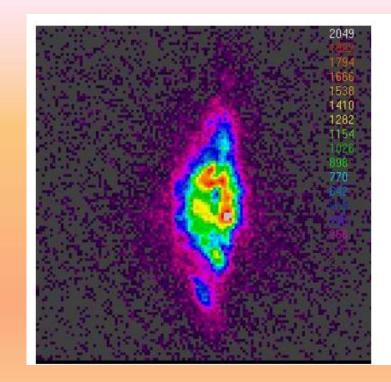
June 2007, DESY

SHORT XFEL BUNCH MEASHUREMENTS

Parameters of FLASH FIR undulator constructed in JINR

Electron beam parameters

Electron energy, GeV	0.5-1
Bunch charge, nC	1
Rms bunch length, μm	50
Normalized emittance, π ·mm·mrad	2
Rms energy spread, MeV	2.5
Undulator	
Period, cm	40
Number of periods	9
Magnetic field, T	0.1-1.1
Output radiation	
Wavelength, μ m	5-200
Peak power, MW	100
Micropulse energy, mJ	1
Micropulse duration, ps	1-10



Coherent radiation of FLASH infrared undulator constructed at JINR measured by **SPIRICON** camera

Parameters of electromagnetic infrared undulator

$$K = 93, 4B_{z[T]} \cdot \lambda_{u[m]}$$

- K=44,8 undulator parameter
- λ_u =40 cm undulator period
- B_z=1,2 T magnetic field.

The wavelength of undulator radiation for first harmonic

$$\lambda = \frac{\lambda_u}{2\gamma^2} \left(1 + \frac{K^2}{2} \right)$$

 λ =107 μm at electron energy of 700 MeV λ =204 μm at electron energy of 500 MeV.

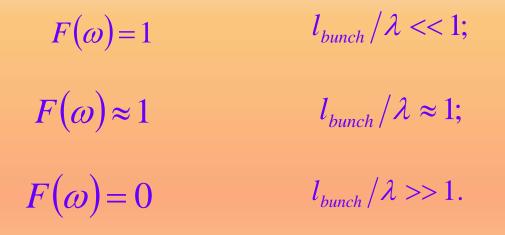
Energy radiated by electron bunch in infrared undulator

$$\varepsilon_{coh} = \pi e^2 A_{jj}^2 \omega K^2 / \left[c \left(1 + K^2 / 2 \right) \right] \times \left[N + N \left(N - 1 \right) \left| \overline{F}(\omega) \right|^2 \right]$$

 $A_{jj}=J_0(q)-J_1(q), J_0, J_1$ -Bessel functions, q=K²/(4(1+K²/2))

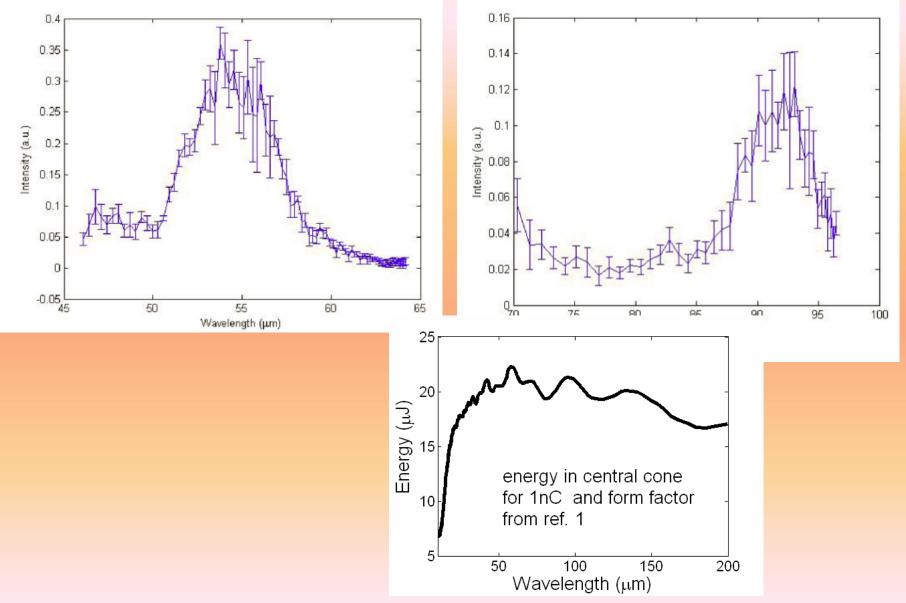
Energy radiated by electron bunch $E \propto p(\omega) \cdot \left(N + N(N-1) |F(\omega)|^2 \right)$

 $p(\omega)$ -energy spectrum radiated by single electron $F(\omega)$ - Fourier transform of the bunch profile function



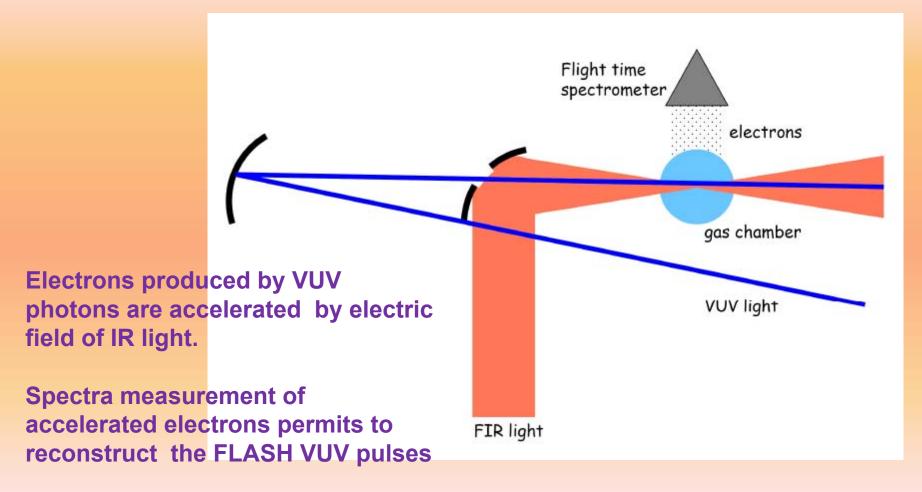
Measurement of energy radiated by bunch versus radiation frequency brings information about Fourier transform of the bunch profile function $F(\omega)$, which gives information about longitudinal bunch shape

FLASH spectral measurements with JINR infrared undulator



FLASH First Pump –Probe experiments with VUV and FIR undulators

Reconstruction of the FLASH VUV pulses

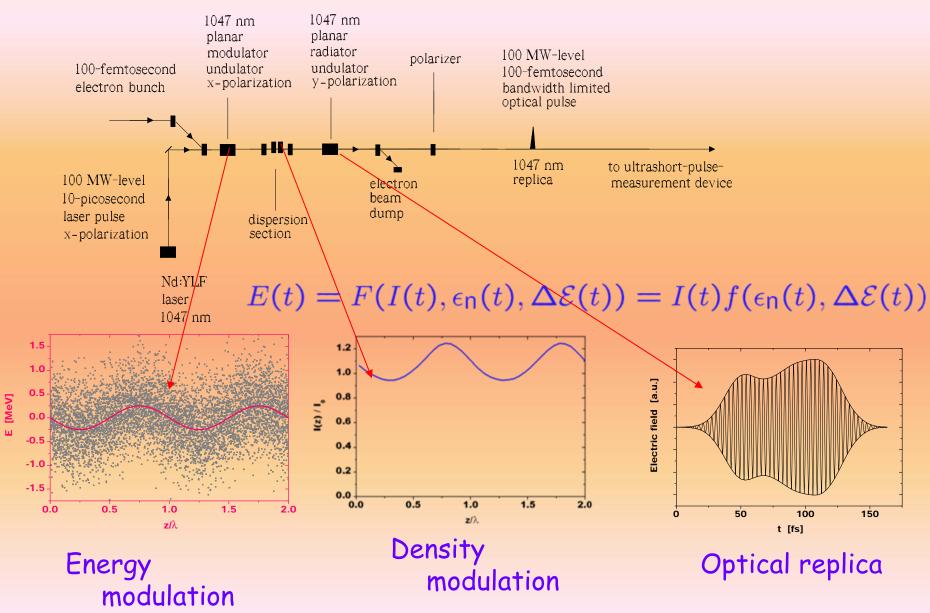


JINR Proposal of XFEL Equipment construction

WP 18 OPTICAL REPLICA

JINR propose to design and to construct the Optical Replica synthesizer (ORS). Optical replica synthesizer is a novel type of electron beam diagnostics. The principle of operation is based on a production of optical replica of the electron bunch with subsequent use of modern optical techniques for deriving properties of the electron bunch (current profile, emittance, energy spread) with a femtosecond resolution. ORS consists of a seed optical laser, two undulators, dispersion section, and optical diagnostic station. Two ORS setups can be installed in the XFEL.

The optical replica synthesis through optical modulation of electron bunch and coherent radiation in the output undulator



XFEL INJECTOR ORS

The injector replica is placed in region between 39-44 m. The total injector replica length is about 5m. The electron energy corresponds to 130 MeV

Modulator			
Undulator period, cm	10		
Magnetic field, T	0.09		
Undulator parameter K	0.84		
Laser wave length, µm	1.047		
Number of periods	5		
Total undulator length with edge poles, m	0.75		
Beta function in undulator, m	4		
Transverse size, μm	250		
Diffraction parameter, N	0.26		
Electron energy modulation by laser, keV	15		

Chicane			
Number of dipole magnets	4		
Magnet length, cm	10		
Magnetic field, kG	1.15		
Bending angle, mrad	26.6		
Parameter R ₅₆ , µm	460		
Total chicane length, cm	75		
Microbanch spread	0.35		
Radiator			
Undulator period, cm	10		
Magnetic field, T	0.09		
Undulator parameter K	0.84		
Laser wave length, µm	1.047		
Number of periods	5		
Total undulator length with edge poles, m	0.75		
Beta function in undulator, m	4		
Transverse size, µm	250		
Diffraction parameter, N	0.25		
Ratio to electron trajectory radius to beam transverse size	10		

JINR Proposal of XFEL Equipment construction

WP 24 CALORIMETRIC SYSTEMS FOR FEL RADIATION MEASHUREMENTS

JINR propose to design, to construct and to delivery MCP-based detectors. MCP stands for microchannel plate are effectively used at FLASH for measurements of FEL radiation in wide dynamic range and they can be applied for SASE XFEL.

WP14 LASER heater

'Laser heater' is a magnet chicane of two meters long with an undulator magnet which the electron beam traverses together with a laser beam. It adjusts the uncorrelated energy spread up to 40 keV. It permits to avoid electron beam instabilities driven by space charge and coherent synchrotron radiation.

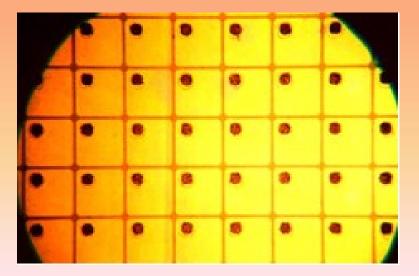
Undulator parameters Number of periods - 10 Period length, cm- 3 Peak field, T- 0.5 Nd:YLF laser (second harmonic), µm -052 Laser power, W- 300 Electron energy modulation -20 keV **JINR Proposal of XFEL Equipment construction**

GaAs HYBRID PIXEL ARRAY DETECTOR

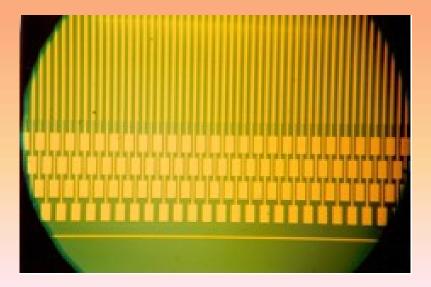
JINR and Tomsk University Collaboration

WP 26 HYBRID PIXEL ARRAY DETECTOR

The main task of XFEL complex – new research of nanostructures with femtoseconds time resolution – requires a new generation of instrumentation and analysis tools - Large area Hybrid Pixel Array Detector.



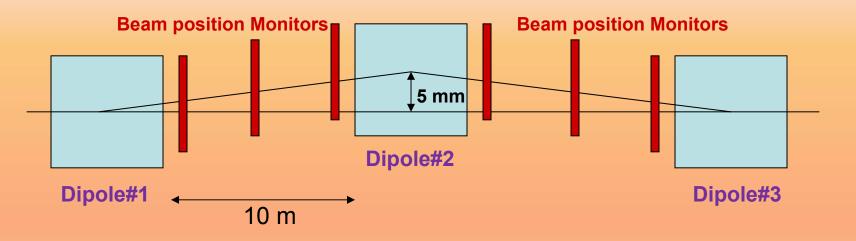
Pixel detector



Strip detector

Method to measure the beam energy in ILC

Magnetic Spectrometer (e.g. proposed in LC-DET-2004-031) JINR-DESY (Zeuthen) collaboration

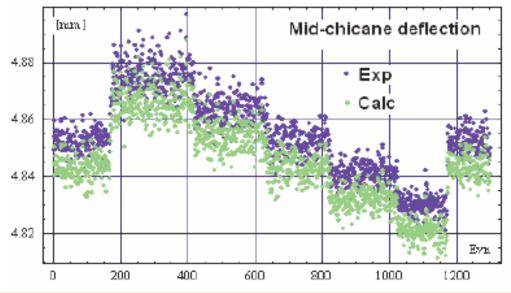


E= 250 GeV, BI = 0.4 Tm, $\sigma_{BPM} = 100 \text{ nm} \rightarrow dE_{b}/E_{b} \sim 5 \times 10^{-5}$

Beam energy measurement is based on precise angular measurement and on precise B-field integral ($\Delta B/B = 2 \ 10^{-5}$) of the spectrometer mag Electron energy measurements at prototype SLAC spectrometer

R. Arnold et al., PAC07, 3085.

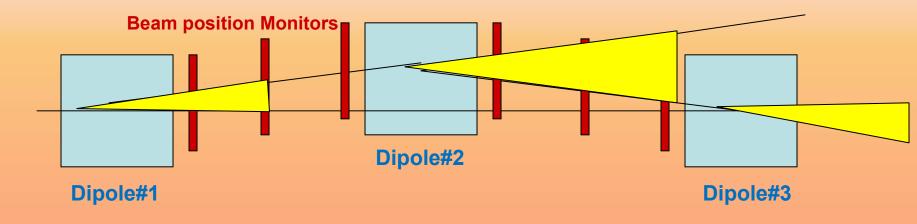
SLAC T-474 project realized in framework of JINR-SLAC-DESY(Zeuthen) collaboration Electron energy - 28.5 GeV beam BPM resolution \approx 1 μ m Accuracy of the magnetic field integral is 100 ppm. Relative electron energy resolution is 2.5·10⁻⁴.



Experimentally measured and calculated mid-chicane beam deflection during 5 steps of energy scan in range ±0.2 GeV

Synchrotron Radiation Fan

K. Hiller, H.J.Schreiber, E. Syresin et al., NIM A 585 (2007) 1191.

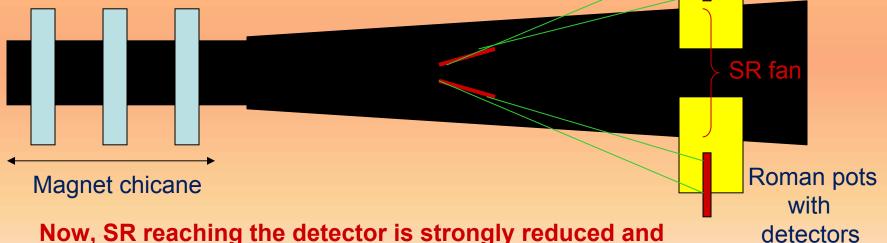


3 radiation fans cover exactly the electron bending angle

 \rightarrow Measurement the width of the fan resp. the position of both edges allows to determine E_b

Due to the large radiation dose expected in the detector

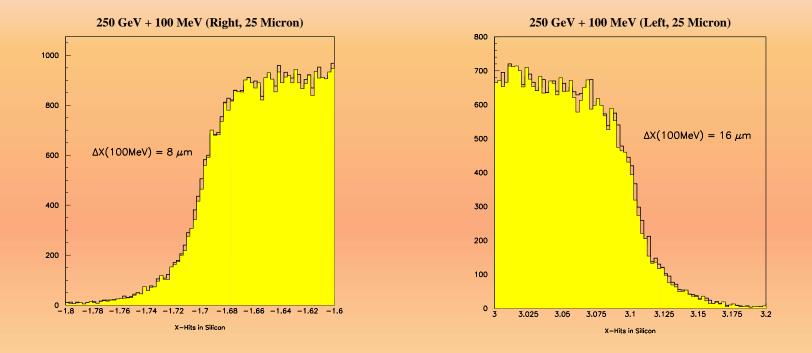
- \rightarrow set-up is supplemented by Rh **mirrors**
 - reflection of only photons < 20 keV, (with total reflection only below critical angle $\varphi_{max} \sim [0.08/E_v(keV)] = 0.4$ mrad)
 - improve of position resolution of incident gammas (to 1-3 µm)
 - sensitive area of the detector reduced to few millimeter (3-5 mm)
 - if some signal amplification is needed, e.g. using gas-amplification detector, the gas pressure can be limited to ~100 atm.



Now, SR reaching the detector is strongly reduced and limited to photons with energies < 20 keV

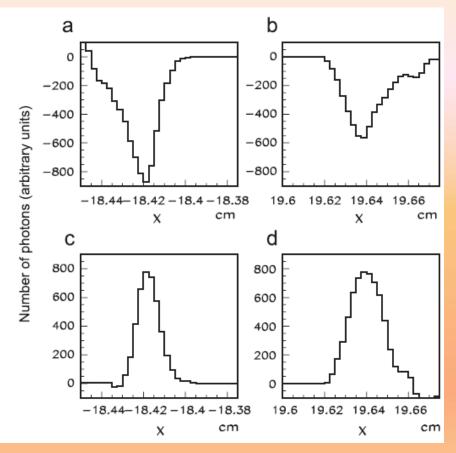
GEANT simulation (including bunch sizes, energy spread, fringe fields) → tracking of SR photons to the detector (Si)

In each plot, two histogram are superimposed - one for nominal $E_b = 250$ GeV, the other (in yellow) for 250 GeV + 100 MeV



→ shift of right edge position in x = 8 μ m; shift of left edge position = 16 μ m so that the total width shrinks by 24 μ m

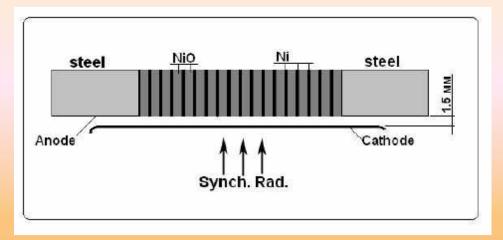
Energy resolution at GIANT simulations



Simulated differences of SR spectra versus x coordinate close to the right (a) and (c) and left (b) and (d) fan edges at electron energies of 250 GeV and 250 \pm 0.25 GeV.

Method of beam energy measurement based on synchrotron radiation (SR) at photon energy 1-20 keV emitted in the dipole magnets of the energy spectrometer is proposed to realization at an uncertainty of $\Delta E/E \cong 5 \cdot 10^{-5}$

GAS AMPLIFICATION DETECTOR



 $N=N_0exp(\alpha d_{c-a})$

P=60 Atm at t=16 C- critical pressure for liquid Xe liquid Xe density is of 3.05 g/cm³

720 Al layers at a thickness of 1 mkm strip pitch is 3 mkm

Number of soft photons at E≈10 keV per strip	N _γ ≈ 10 ⁶
Number of secondary electrons per strip	N _e ≈10 ⁸
After amplification at K=10	N _e ≈10 ⁹
The signal at amplifier conversion of 5 V/1 nC	V≈1.5 V

High pressure system for SR Gas amplification detector



A prototype of a gas amplification strip detector with 48 channels and resolution of 3 μ m was constructed. The construction of high pressure (150 atm) chamber for a gas amplification strip detector was performed. The assembling of SR is planed in near future.

